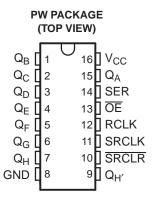


## **FEATURES**

- Qualified for Automotive Applications
- Operating Range 2-V to 5.5-V V<sub>CC</sub>
- 8-Bit Serial-In, Parallel-Out Shift
- Shift Register Has Direct Clear



# **DESCRIPTION/ORDERING INFORMATION**

The SN74AHC595 contains an 8-bit serial-in, parallel-out shift register that feeds an 8-bit D-type storage register. The storage register has parallel 3-state outputs. Separate clocks are provided for both the shift and storage registers. The shift register has a direct overriding clear (SRCLR) input, serial (SER) input, and a serial output for cascading. When the output-enable ( $\overline{OE}$ ) input is high, all outputs, except Q<sub>H'</sub>, are in the high-impedance state.

Both the shift-register clock (SRCLK) and storage-register clock (RCLK) are positive-edge triggered. If both clocks are connected together, the shift register always is one clock pulse ahead of the storage register.

#### **ORDERING INFORMATION**<sup>(1)</sup>

T <sub>A</sub>	PACK	AGE <sup>(2)</sup>	ORDERABLE PART NUMBER	TOP-SIDE MARKING	
–40°C to 125°C	TSSOP – PW	Reel of 2000	SN74AHC595QPWRQ1	HA595Q	

(1) For the most current package and ordering information, see the Package Option Addendum at the end of this document, or see the TI web site at www.ti.com.

(2) Package drawings, thermal data, and symbolization are available at www.ti.com/packaging.

		INPUTS			FUNCTION
SER	SRCLK	SRCLR	RCLK	ŌĒ	FUNCTION
Х	Х	Х	Х	Н	Outputs $Q_A - Q_H$ are disabled.
Х	Х	Х	Х	L	Outputs $Q_A - Q_H$ are enabled.
Х	х	L	Х	Х	Shift register is cleared.
L	↑	н	х	Х	First stage of the shift register goes low. Other stages store the data of previous stage, respectively.
Н	↑	н	х	Х	First stage of the shift register goes high. Other stages store the data of previous stage, respectively.
Х	Х	Х	<b>↑</b>	Х	Shift-register data is stored into the storage register.

#### FUNCTION TABLE

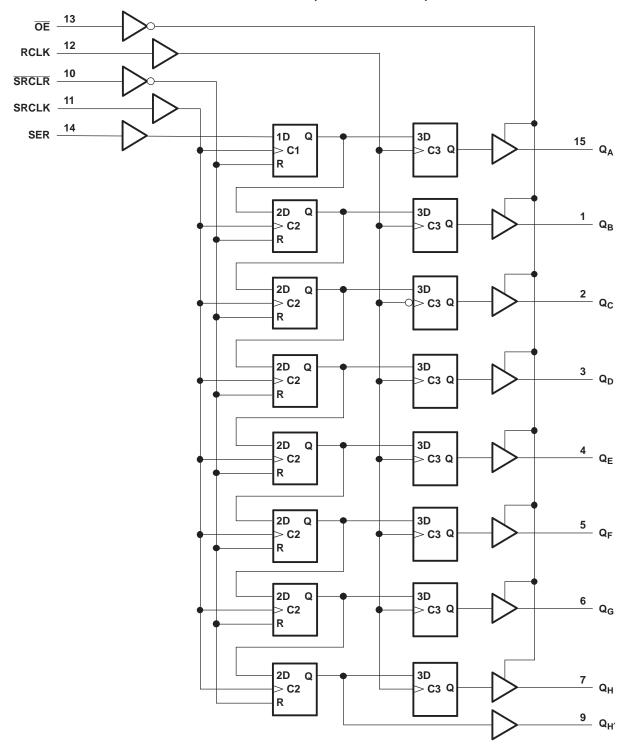


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LOGIC DIAGRAM (POSITIVE LOGIC)



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	TIMING DIAGRAM
SRCLK	
SER	
RCLK	
SRCLR	
ŌĒ	
Q <sub>A</sub>	
Q <sub>B</sub>	
Q <sub>C</sub>	
QD	
Q <sub>E</sub>	
Q <sub>F</sub>	
Q <sub>G</sub>	7 [
Q <sub>H</sub>	
Q <sub>H</sub>	
	J [

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#### ABSOLUTE MAXIMUM RATINGS<sup>(1)</sup>

over operating free-air temperature range (unless otherwise noted)

$V_{CC}$	Supply voltage range		–0.5 V to 7 V
VI	Input voltage range <sup>(2)</sup>		–0.5 V to 7 V
Vo	Output voltage range <sup>(2)</sup>		-0.5 V to V <sub>CC</sub> + 0.5 V
I <sub>IK</sub>	Input clamp current	V <sub>1</sub> < 0	–20 mA
I <sub>OK</sub>	Output clamp current	$V_{O} < 0$ or $V_{O} > V_{CC}$	±20 mA
I <sub>O</sub>	Continuous output current	$V_{O} = 0$ to $V_{CC}$	±25 mA
	Continuous current through $V_{CC}$ or GND	±75 mA	
$\theta_{JA}$	Package thermal impedance, junction to free	ee air <sup>(3)</sup>	108°C/W
T <sub>stg</sub>	Storage temperature range		–65°C to 150°C

(1) Stresses beyond those listed under *absolute maximum ratings* may cause permanent damage to the device. These are stress ratings only, and functional operation of the device at these or any other conditions beyond those indicated under *recommended operating conditions* is not implied. Exposure to absolute-maximum-rated conditions for extended periods may affect device reliability.

(2) The input and output voltage ratings may be exceeded if the input and output current ratings are observed.

(3) The package thermal impedance is calculated in accordance with JESD 51-7.

## **RECOMMENDED OPERATING CONDITIONS**<sup>(1)</sup>

			MIN	MAX	UNIT
$V_{CC}$	Supply voltage		2	5.5	V
		$V_{CC} = 2 V$	1.5		
$V_{\text{IH}}$	High-level input voltage	$V_{CC} = 3 V$	2.1		V
		V <sub>CC</sub> = 5.5 V	3.85		
		V <sub>CC</sub> = 2 V		0.5	
VIL	Low-level input voltage	$V_{CC} = 3 V$		0.9	V
		V <sub>CC</sub> = 5.5 V		1.65	
VI	Input voltage		0	5.5	V
Vo	Output voltage		0	$V_{CC}$	V
		$V_{CC} = 2 V$		-50	μΑ
I <sub>OH</sub>	High-level output current	$V_{CC} = 3.3 \text{ V} \pm 0.3 \text{ V}$		-4	
		$V_{CC} = 5 \text{ V} \pm 0.5 \text{ V}$		-8	mA
		$V_{CC} = 2 V$		50	μΑ
I <sub>OL</sub>	Low-level output current	$V_{CC} = 3.3 \text{ V} \pm 0.3 \text{ V}$			
		$V_{CC} = 5 V \pm 0.5 V$		8	mA
A+/A.,	Input transition rise or fall rate	$V_{CC} = 3.3 \text{ V} \pm 0.3 \text{ V}$		100	<b>~~</b> //
Δt/Δv	Input transition rise or fall rate	$V_{CC} = 5 \text{ V} \pm 0.5 \text{ V}$		20	ns/V
т	I-suffix devices		-40	85	°C
T <sub>A</sub>	Operating free-air temperature	Q-suffix devices	-40	125	°L

 All unused inputs of the device must be held at V<sub>CC</sub> or GND to ensure proper device operation. Refer to the TI application report, Implications of Slow or Floating CMOS Inputs, literature number SCBA004.

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**EXAS** 



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# **ELECTRICAL CHARACTERISTICS**

over recommended operating free-air temperature range (unless otherwise noted)

	TEST CONDITIONS	V	T,	₄ = 25°C		MINI	МАХ	UNIT
PARAMETER	TEST CONDITIONS	V <sub>cc</sub>	MIN	TYP	MAX	MIN		
		2 V	1.9	2		1.9		
	I <sub>OH</sub> = -50 μA	3 V	2.9	3		2.9		
V <sub>OH</sub>		4.5 V	4.4	4.5		4.4		V
	$I_{OH} = -4 \text{ mA}$	3 V	2.58			2.48		
	$I_{OH} = -8 \text{ mA}$	4.5 V	3.94			3.8		
		2 V			0.1		0.1	
	I <sub>OL</sub> = 50 μA	3 V			0.1		0.1	
V <sub>OL</sub>		4.5 V			0.1		0.1	V
	I <sub>OL</sub> = 4 mA	3 V			0.36		0.44	
	I <sub>OL</sub> = 8 mA	4.5 V			0.36		0.44	
l	V <sub>1</sub> = 5.5 V or GND	0 V to 5.5 V			±0.1		±1	μA
I <sub>OZ</sub>	$\begin{array}{c} Q_{A} - Q_{H}, \ V_{I} = V_{CC} \ or \ GND, \\ V_{O} = V_{CC} \ or \ GND, \ \overline{OE} = V_{IH} \ or \ V_{IL} \end{array}$	5.5 V			±0.25		±10	μA
I <sub>CC</sub>	$V_{I} = V_{CC}$ or GND, $I_{O} = 0$	5.5 V			4		40	μA
Ci	$V_1 = V_{CC}$ or GND	5 V		3	10		10	pF
Co	$V_0 = V_{CC}$ or GND	5 V		5.5				pF

#### TIMING REQUIREMENTS

 $V_{CC} = 3.3 \text{ V} \pm 0.3 \text{ V}$ , over recommended operating free-air temperature range (unless otherwise noted) (see Figure 1)

			T <sub>A</sub> = 25°C	MIN	МАХ	UNIT	
			MIN MAX	IVIIIN	WIAA	UNIT	
		SRCLK high or low	5.5	6.5			
t <sub>w</sub>	Pulse duration	RCLK high or low	5.5	6.5		ns	
		SRCLR low		6			
		SER before SRCLK↑	3.5	4.5			
	Cotup time	SRCLK↑ before RCLK↑ <sup>(1)</sup>	8	9.5			
t <sub>su</sub>	Setup time	SRCLR low before RCLK↑	8	10		ns	
		SRCLR high (inactive) before SRCLK↑	3	4			
t <sub>h</sub>	Hold time	SER after SRCLK↑	1.5	2.5		ns	

(1) This setup time allows the storage register to receive stable data from the shift register. The clocks can be tied together, in which case the shift register is one clock pulse ahead of the storage register.

## TIMING REQUIREMENTS

V<sub>CC</sub> = 5 V ± 0.5 V, over recommended operating free-air temperature range (unless otherwise noted) (see Figure 1)

			T <sub>A</sub> = 25°C	MIN	МАХ	UNIT	
			MIN MAX		WAA	UNIT	
		SRCLK high or low	5	6			
t <sub>w</sub>	Pulse duration	RCLK high or low	5	6		ns	
		SRCLR low	5.2	6.2			
		SER before SRCLK↑	3	4			
	Catur time	SRCLK↑ before RCLK↑ <sup>(1)</sup>	5	6		20	
t <sub>su</sub>	Setup time	SRCLR low before RCLK↑	5	6		ns	
		SRCLR high (inactive) before SRCLK↑	2.5	3.5			
t <sub>h</sub>	Hold time	SER after SRCLK↑	2	3		ns	

(1) This setup time allows the storage register to receive stable data from the shift register. The clocks can be tied together, in which case the shift register is one clock pulse ahead of the storage register.

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### SWITCHING CHARACTERISTICS

V<sub>CC</sub> = 3.3 V ± 0.3 V, over recommended operating free-air temperature range (unless otherwise noted) (see Figure 1)

PARAMETER	FROM	TO LOAD		T,	₄ = 25°C		MIN	МАХ	UNIT
FARAMETER	(INPUT)	(OUTPUT)	CAPACITANCE	MIN	TYP	MAX	WIIIN	IVIAA	UNIT
f <sub>max</sub>			C <sub>L</sub> = 50 pF	55	105		40		MHz
t <sub>PLH</sub>	RCLK	Q <sub>A</sub> –Q <sub>H</sub>	C = 50  pF		7.9	15.4	1	20	20
t <sub>PHL</sub>	RULK	QA-QH	C <sub>L</sub> = 50 pF		7.9	15.4	1	20	ns
t <sub>PLH</sub>	SRCLK	Q <sub>H'</sub>	C <sub>L</sub> = 50 pF		9.2	16.5	1	21.5	ns
t <sub>PHL</sub>	SKOLK	QH,	0L = 30 pi		9.2	16.5	1	21.5	113
t <sub>PHL</sub>	SRCLR	Q <sub>H'</sub>	$C_L = 50 \text{ pF}$		9	16.3	1	20.2	ns
t <sub>PZH</sub>	ŌĒ	Q <sub>A</sub> –Q <sub>H</sub>	$C_{1} = 50  pF$		7.8	15	1	20	ns
t <sub>PZL</sub>	UE	QA-QH	$O_L = 50 \text{ pr}$		9.6	15	1	20	115
t <sub>PHZ</sub>	ŌĒ	0.0	C <sub>L</sub> = 50 pF		8.1	15.7	1	19.2	ns
t <sub>PLZ</sub>	OL	Q <sub>A</sub> –Q <sub>H</sub>	$O_L = 50 \text{ pm}$		9.3	15.7	1	19.2	115

# SWITCHING CHARACTERISTICS

V<sub>CC</sub> = 5 V ± 0.5 V, over recommended operating free-air temperature range (unless otherwise noted) (see Figure 1)

PARAMETER	FROM	то	LOAD	T,	₄ = 25°C		MIN	МАХ	UNIT
PARAMETER	(INPUT)	(OUTPUT)	CAPACITANCE	MIN	TYP	MAX	IVIIIN	WAA	UNIT
f <sub>max</sub>			C <sub>L</sub> = 50 pF	95	140		75		MHz
t <sub>PLH</sub>	RCLK	0.0	$C_{1} = 50  pF$		5.6	9.4	1	13.5	2
t <sub>PHL</sub>	RULK	Q <sub>A</sub> –Q <sub>H</sub>	$C_L = 50 \text{ pr}$		5.6	9.4	1	13.5	ns
t <sub>PLH</sub>	SRCLK	0	C = 50  pc		6.4	10.2	1	14.4	2
t <sub>PHL</sub>	SKULK	Q <sub>H'</sub>	C <sub>L</sub> = 50 pF		6.4	10.2	1	14.4	ns
t <sub>PHL</sub>	SRCLR	Q <sub>H</sub> '	C <sub>L</sub> = 50 pF		6.4	10	1	14.1	ns
t <sub>PZH</sub>	ŌĒ	0.0			5.7	10.6	1	15	2
t <sub>PZL</sub>	UE	Q <sub>A</sub> –Q <sub>H</sub>	C <sub>L</sub> = 50 pF		6.8	10.6	1	15	ns
t <sub>PHZ</sub>	ŌĒ	0.0	C = 50  pF		3.5	10.3	1	14	20
t <sub>PLZ</sub>	UE	Q <sub>A</sub> –Q <sub>H</sub>	C <sub>L</sub> = 50 pF		3.4	10.3	1	14	ns

## **OPERATING CHARACTERISTICS**

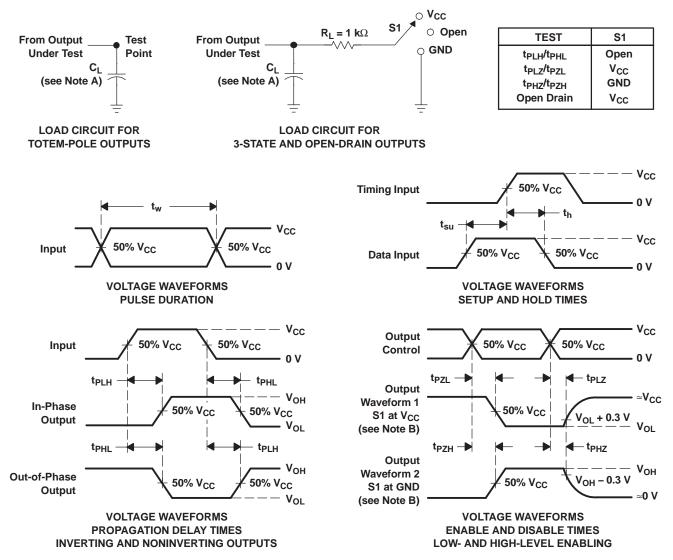
 $V_{CC} = 5 \text{ V}, \text{ } \text{T}_{\text{A}} = 25^{\circ}\text{C} \text{ (unless otherwise noted)}$ 

	PARAMETER	TEST CONDITIONS	TYP	UNIT
C <sub>pd</sub>	Power dissipation capacitance	No load, f = 10 MHz	114	pF



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#### PARAMETER MEASUREMENT INFORMATION



NOTES: A. C<sub>L</sub> includes probe and jig capacitance.

- B. Waveform 1 is for an output with internal conditions such that the output is low, except when disabled by the output control. Waveform 2 is for an output with internal conditions such that the output is high, except when disabled by the output control.
- C. All input pulses are supplied by generators having the following characteristics: PRR  $\leq$  1 MHz, Z<sub>Q</sub> = 50  $\Omega$ , t<sub>r</sub>  $\leq$  3 ns, t<sub>f</sub>  $\leq$  3 ns.
- D. The outputs are measured one at a time, with one input transition per measurement.

#### Figure 1. Load Circuit and Voltage Waveforms



24-Jan-2013

# PACKAGING INFORMATION

Orderable Device	Status	Package Type	•	Pins	Package Qty	Eco Plan	Lead/Ball Finish	MSL Peak Temp	Op Temp (°C)	Top-Side Markings	Samples
	(1)		Drawing			(2)		(3)		(4)	
SN74AHC595QPWRQ1	ACTIVE	TSSOP	PW	16	2000	Green (RoHS & no Sb/Br)	CU NIPDAU	Level-1-260C-UNLIM	-40 to 125	HA595Q	Samples

<sup>(1)</sup> The marketing status values are defined as follows:

**ACTIVE:** Product device recommended for new designs.

LIFEBUY: TI has announced that the device will be discontinued, and a lifetime-buy period is in effect.

**NRND:** Not recommended for new designs. Device is in production to support existing customers, but TI does not recommend using this part in a new design.

PREVIEW: Device has been announced but is not in production. Samples may or may not be available.

**OBSOLETE:** TI has discontinued the production of the device.

<sup>(2)</sup> Eco Plan - The planned eco-friendly classification: Pb-Free (RoHS), Pb-Free (RoHS Exempt), or Green (RoHS & no Sb/Br) - please check http://www.ti.com/productcontent for the latest availability information and additional product content details.

**TBD:** The Pb-Free/Green conversion plan has not been defined.

**Pb-Free (RoHS):** TI's terms "Lead-Free" or "Pb-Free" mean semiconductor products that are compatible with the current RoHS requirements for all 6 substances, including the requirement that lead not exceed 0.1% by weight in homogeneous materials. Where designed to be soldered at high temperatures, TI Pb-Free products are suitable for use in specified lead-free processes. **Pb-Free (RoHS Exempt):** This component has a RoHS exemption for either 1) lead-based flip-chip solder bumps used between the die and package, or 2) lead-based die adhesive used between

the die and leadframe. The component is otherwise considered Pb-Free (RoHS compatible) as defined above.

Green (RoHS & no Sb/Br): TI defines "Green" to mean Pb-Free (RoHS compatible), and free of Bromine (Br) and Antimony (Sb) based flame retardants (Br or Sb do not exceed 0.1% by weight in homogeneous material)

<sup>(3)</sup> MSL, Peak Temp. -- The Moisture Sensitivity Level rating according to the JEDEC industry standard classifications, and peak solder temperature.

<sup>(4)</sup> Only one of markings shown within the brackets will appear on the physical device.

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#### OTHER QUALIFIED VERSIONS OF SN74AHC595-Q1 :

• Catalog: SN74AHC595



PACKAGE OPTION ADDENDUM

24-Jan-2013

• Catalog - TI's standard catalog product

# **PACKAGE MATERIALS INFORMATION**

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## **TAPE AND REEL INFORMATION**





# QUADRANT ASSIGNMENTS FOR PIN 1 ORIENTATION IN TAPE



*All dimensions are nominal												
Device	Package Type	Package Drawing		SPQ	Reel Diameter (mm)	Reel Width W1 (mm)	A0 (mm)	B0 (mm)	K0 (mm)	P1 (mm)	W (mm)	Pin1 Quadrant
SN74AHC595QPWRQ1	TSSOP	PW	16	2000	330.0	12.4	6.9	5.6	1.6	8.0	12.0	Q1

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# PACKAGE MATERIALS INFORMATION

14-Mar-2013



\*All dimensions are nominal

Device	Package Type	Package Drawing	Pins	SPQ	Length (mm)	Width (mm)	Height (mm)
SN74AHC595QPWRQ1	TSSOP	PW	16	2000	367.0	367.0	35.0

PW (R-PDSO-G16)

PLASTIC SMALL OUTLINE



NOTES:

A. All linear dimensions are in millimeters. Dimensioning and tolerancing per ASME Y14.5M-1994.  $\beta$ . This drawing is subject to change without notice.

Body length does not include mold flash, protrusions, or gate burrs. Mold flash, protrusions, or gate burrs shall not exceed 0,15 each side.

Body width does not include interlead flash. Interlead flash shall not exceed 0,25 each side.

E. Falls within JEDEC MO-153



# PW (R-PDSO-G16)

# PLASTIC SMALL OUTLINE



- B. This drawing is subject to change without notice.
- C. Publication IPC-7351 is recommended for alternate designs.
- D. Laser cutting apertures with trapezoidal walls and also rounding corners will offer better paste release. Customers should contact their board assembly site for stencil design recommendations. Refer to IPC-7525 for other stencil recommendations.
- E. Customers should contact their board fabrication site for solder mask tolerances between and around signal pads.



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